

BSC019N04NS G-VB Datasheet N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)	
40	0.0025 at V _{GS} = 10 V	120	38 nC	
	0.0028 at V _{GS} = 6.5 V	105	30 110	

FEATURES

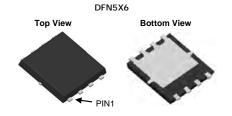
• Halogen-free According to IEC 61249-2-21 Definition

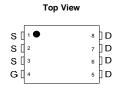


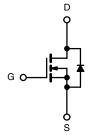
- Trench Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- Synchronous Rectification
- Secondary Side DC/DC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	$I_A = 25 ^{\circ}\text{C}$, unles	ss otherwise not	ed		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	40	V		
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		120		
Continuous Drain Current (T _{.1} = 150 °C)	$T_C = 70 ^{\circ}C$	I _D	80		
Continuous Brain Current (1) = 150 °C)	T _A = 25 °C	υ υ	33 ^{b, c}		
	T _A = 70 °C		26 ^{b, c}	Α	
Pulsed Drain Current		I _{DM}	360		
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	100		
Continuous Source-Drain Diode Current	T _A = 25 °C	'S	4.9 ^{b, c}		
ingle Pulse Avalanche Current		I _{AS}	40		
Single Pulse Avalanche Energy	e Pulse Avalanche Energy		80	mJ	
	T _C = 25 °C		83		
Maximum Power Dissipation	T _C = 70 °C	P _D	53	w	
	T _A = 25 °C	' b	5.4 ^{b, c}		
	T _A = 70 °C		3.4 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	18	23	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.0	1.5	O/ VV

- a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 90 °C/W.
- e. Calculated based on maximum junction temperature. Package limitation current is 80 A.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	/ _{DS} /T _J		43			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
·	1	V _{DS} = 40 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	100			Α	
	Б	V _{GS} = 10 V, I _D = 20 A		0.0025		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} =6.5 V, I _D = 20 A		0.0028			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 20 A		102		S	
Dynamic ^b		<u> </u>				1	
Input Capacitance	C _{iss}			4750		pF	
Output Capacitance	C _{oss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz		610			
Reverse Transfer Capacitance	C _{rss}			275			
Total Cata Chausa		$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$	78 11	117			
Total Gate Charge	Qg			38	57	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		13			
Gate-Drain Charge	Q _{gd}			11			
Gate Resistance	R_g	f = 1 MHz	0.2	0.7	1.4	Ω	
Turn-On Delay Time	t _{d(on)}			14	25		
Rise Time	t _r	$V_{DD} = 20 \text{ V}, R_L = 2 \Omega$		9	18	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		41	65		
Fall Time	t _f			9	18		
Turn-On Delay Time	t _{d(on)}			33	42	113	
Rise Time	t _r	$V_{DD} = 20 \text{ V}, R_L = 2 \Omega$		22	35		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		42	65		
Fall Time	t _f			13	25		
Drain-Source Body Diode Characteris	stics	,		, ,		1	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C		50		А	
Pulse Diode Forward Current ^a	I _{SM}			60			
Body Diode Voltage	V_{SD}	I _S = 5 A		0.75	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			40	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 10 A, dl/dt = 100 A/μs, T _{.I} = 25 °C		48	72	nC	
Reverse Recovery Fall Time	t _a	1 _F = 10 Λ, αι/αι = 100 Λ/μ5, 1 _J = 25 0		24		200	
Reverse Recovery Rise Time	t _b	1		16		ns	

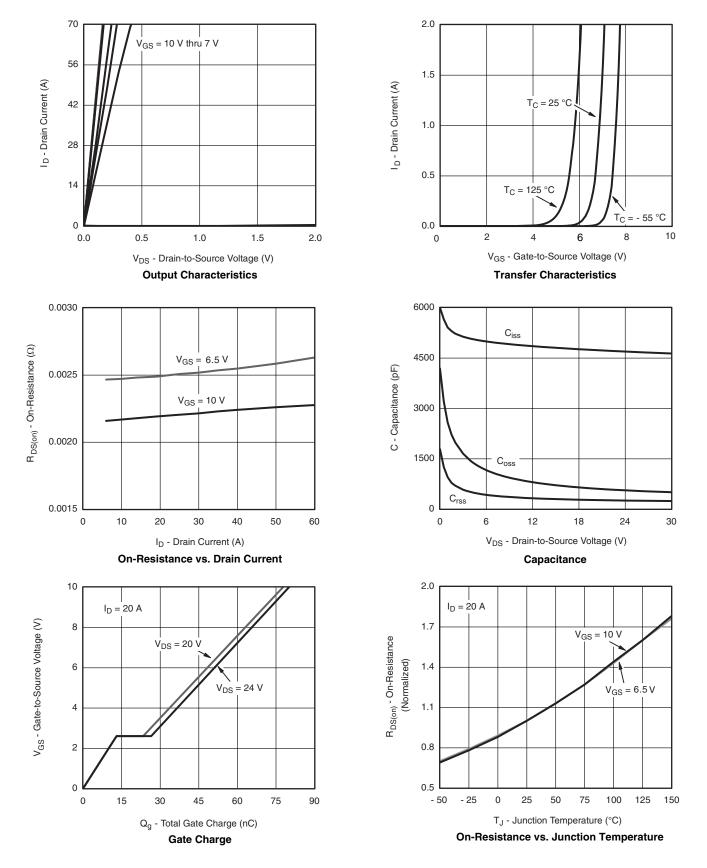
Notes

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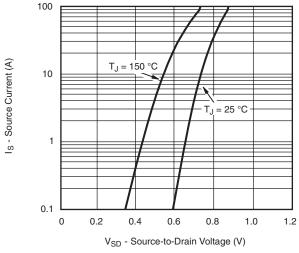
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

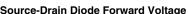
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

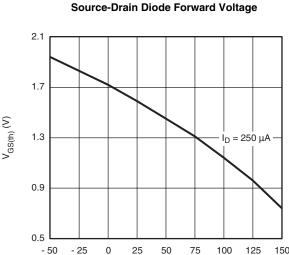




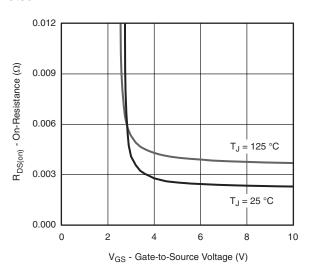




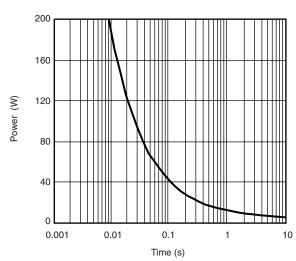




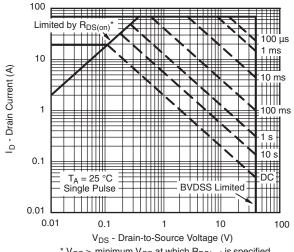
T_J - Temperature (°C) **Threshold Voltage**



On-Resistance vs. Gate-to-Source Voltage



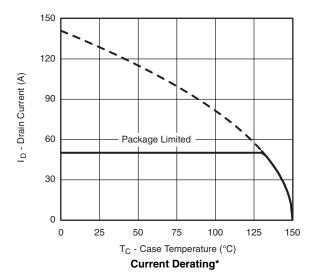
Single Pulse Power, Junction-to-Ambient

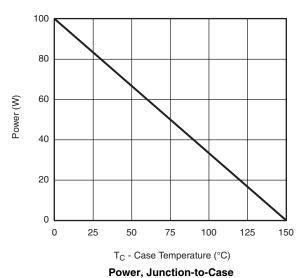


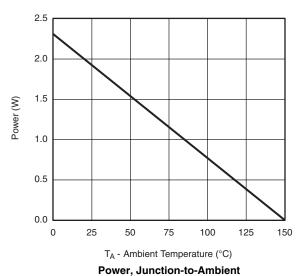
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient



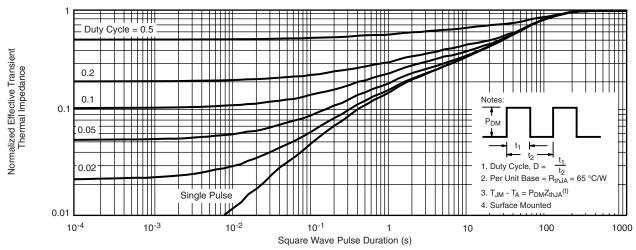




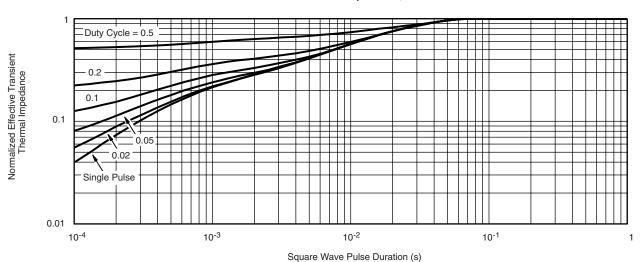


* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

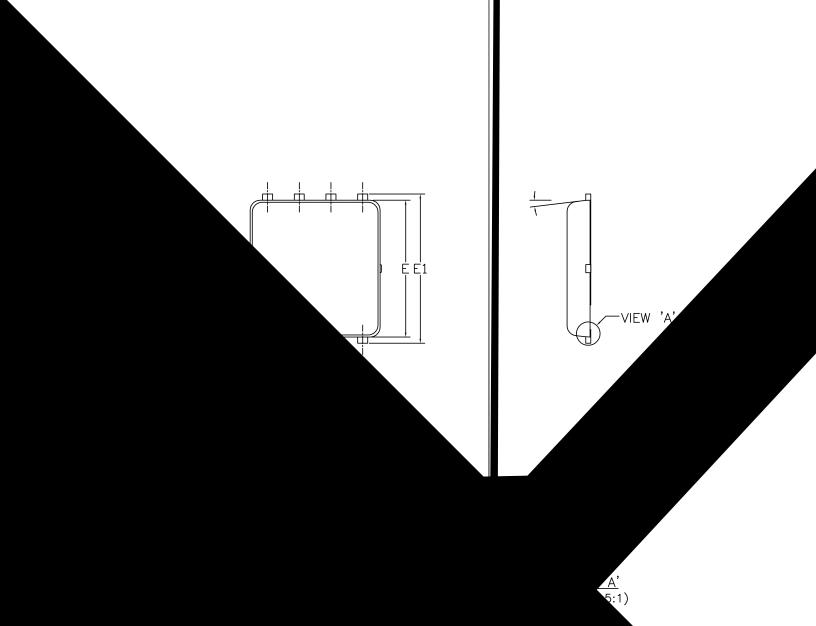




Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



INCHES



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